Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10574468	MIURA ET AL.
Examiner	Art Unit

2872

SEARCHED			
Class	Subclass	Date	Examiner

DEREK S CHAPEL

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted with Arnel Lavarias about the case	4/10/2008	DSC		
EAST Class/Subclass Search: 359/1, 3, 10, 15, 28, 30, 32, 34-35, 900 (text only)	4/9/2008	DSC		
EAST text search	4/9/2008	DSC		
EAST Class/Subclass Search: 369/93-94, 99, 103, 272.1, 275.1-275.2 (text only, see attached)	11/25/2008	DSC		
EAST Update Search	11/25/2008	DSC		
Consulted with Arnel Lavarias about the rejections.	11/25/2008	DSC		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
	Interference Search, see .clm. search	4/11/2008	DSC	
	Updated Interference Search, see .clm. search attached	11/25/2008	DSC	

/D. S. C./ Examiner.Art Unit 2872	

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